

Issue Classification		Application/Control No. 10749240		Applicant(s)/Patent under Reexamination AHN, KIL-JAE	
		Examiner Kaplan, Hai I		Art Unit 2836	
ORIGINAL					
				INTERNATIONAL CLASSIFICATION	
CLASS		SUBCLASS		CLAIMED	
180		326		B 6 0	K 26 / 02
				B 6 0	K 20 / 04
				B 6 0	L 1 / 00
				B 6 0	L 3 / 04
CROSS REFERENCE(S)					
SUBCLASS (ONE SUBCLASS PER BLOCK)					
180		277	279		
307		10.1			
/ / /					
Hai I. Kaplan (Assistant Examiner)		10/31/06 (Date)		Total Claims Allowed: 7	
(Legal Instruments Examiner)		BRIAN SIRCUS (Primary Examiners) SUPVISORY PATENT EXAMINER TECHNOLOGY CENTER 2800 (Date)		O.G. Print Claim(s) 1	
				O.G. Print Figure 2	

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